

**Notice of References Cited**

Application/Control No.

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Applicant(s)/Patent Under

Reexamination

HAYAKAWA ET AL.

Examiner

Ahmed N Sefer

Art Unit

2826

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**U.S. PATENT DOCUMENTS**

*		Document Number	Date	Name	Classification	
		Country Code-Number-Kind Code	MM-YYYY			
	A	US-6,048,758	04-2000	Yamazaki et al	438	166
	B	US-2001/0004121	06-2001	Sakami et al	257	347
	C	US-				
	D	US-				
	E	US-				
	F	US-				
	G	US-				
	H	US-				
	I	US-				
	J	US-				
	K	US-				
	L	US-				
	M	US-				

**FOREIGN PATENT DOCUMENTS**

*		Document Number	Date	Country	Name	Classification	
		Country Code-Number-Kind Code	MM-YYYY				
	N	JP 8-64834	03-1996	Japan	Yamazki et el	--	--
	O						
	P						
	Q						
	R						
	S						
	T						

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

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